AN11006 Single stage 2.3_2.7GHz LNA with BFU730F Rev 2 - 27 October 2011

Application note

Info	Content
Keywords	BFU730F, LNA, 2.3-2.7 GHz, WiMAX, WLAN, ISM, LTE
Abstract	The document provides circuit, layout, BOM and performance information on 2.3-2.7 GHz LNA equipped with NXP's BFU730F wide band transistor.
	This Application note is related to evaluation board OM7690/BFU730F,598 12nC 934065627598



Revision history

Rev	Date	Description
2.0	20112710	Schematic updated
1.0	20110106	Initial document.

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1. Introduction

The BFU730F is a discrete HBT that is produced using NXP Semiconductors' advanced 110 GHz f_T SiGe:C BiCmos process. SiGe:C is a normal silicon germanium process with the addition of Carbon in the base layer of the NPN transistor. The presence of carbon in the base layer suppresses the boron diffusion during wafer processing. This allows steeper and narrower SiGe HBT base and a heavier doped base. As a result, lower base resistance, lower noise and higher cut off frequency can be achieved.

The BFU730F is one of a series of transistors made in SiGe:C.

BFU710F, BFU760 and BFU790 are the other types, BFU710 is intended for ultra low current applications. The BFU760F and BFU790F are high current types and are intended for application where linearity is key.

The BFU7XXF are ideal in all kind of applications where cost matters. It also gives design flexibility.

2. Requirements and design of the 2.3-2.7GHz GHz LNA

The BFU730 2.3-2.7GHz LNA EVB simplifies the evaluation of the BFU730 wideband transistor, for this frequency range, in which e.g. WLAN, Bluetooth, WiMax, LTE etc systems are present. The EVB enables testing of the device performance and requires no additional support circuitry. The board is fully assembled with BFU730, including input- and output matching, to optimize the performance. The input match is a compromise between best noise figure and good Input return loss. The board is supplied with two SMA connectors for input and output connection to RF test equipment.

Table 1. Target spec.

Target specification of the 2.3-2.7 GHz LNA.

Vcc	lcc	NF	Gain	IRL	ORL
3	10	<1dB	>18	>10	>10
V	mA	dB	dB	dB	dB

3. Design

The 2.3_2.7 GHz LNA consists of one stage grounded emitter BFU730F amplifier. For this amplifier 11 external components are used, for matching, biasing and decoupling.

The design has been conducted using Agilent's Advanced Design System (ADS). The 2D EM Momentum tool has been used to co-simulate the PCB. Results are given in paragraph <u>4.5</u>.

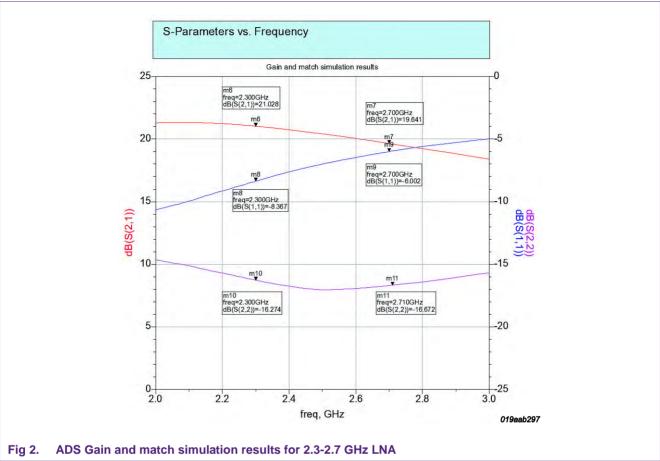
The LNA shows a gain of 20 dB, NF of 0.8 dB, input P1dB of -16.5 dBm and an input IP3 of 1.5 dBm

The LNA shown in this application note is unconditional stable 10 MHz-20 GHz.

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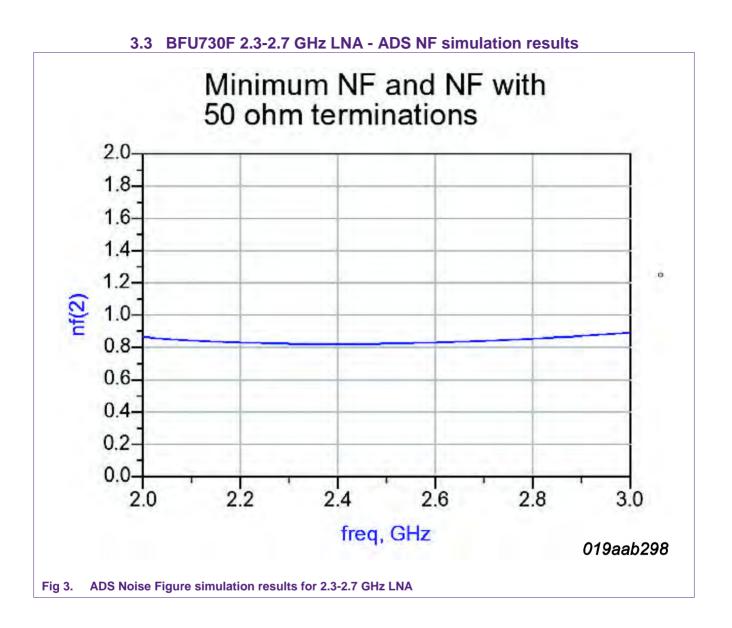


3.1 BFU730F 2.3-2.7 GHz LNA-ADS Simulation circuit

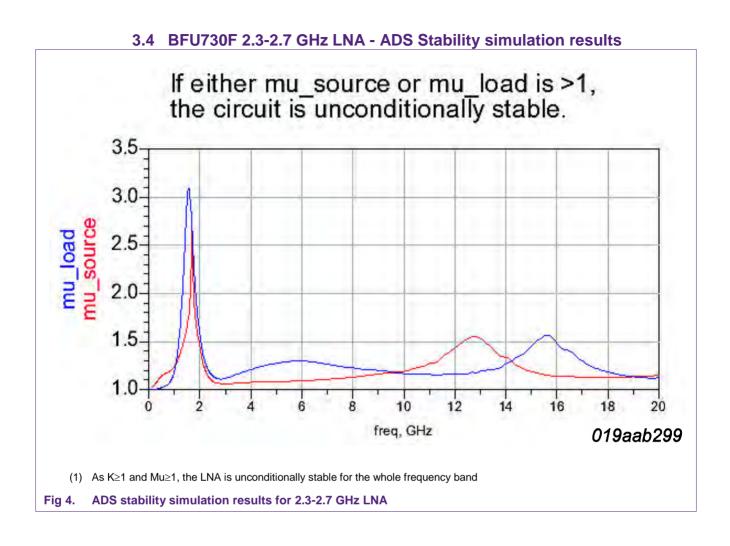


3.2 BFU730F 2.3-2.7 GHz LNA - ADS Gain and match simulation results

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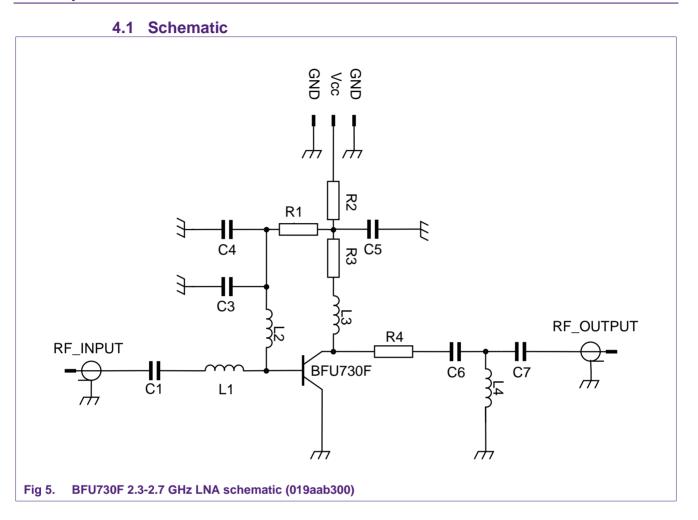


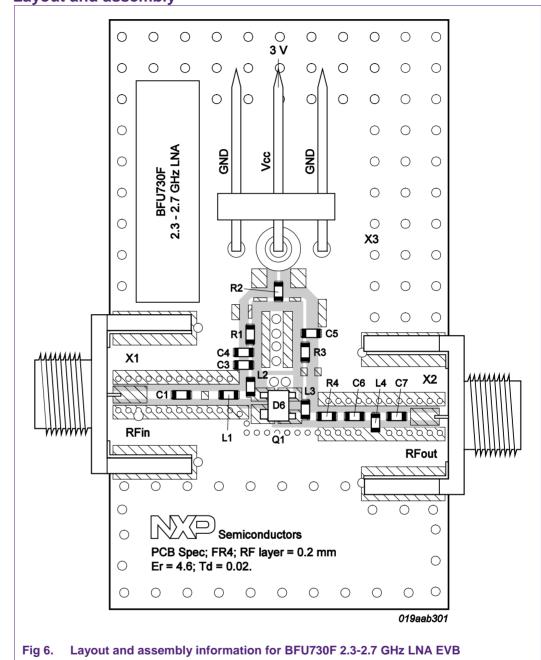
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4. Implementation





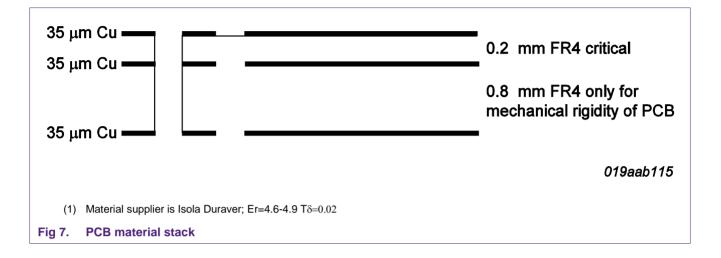
4.2 Layout and assembly

Designator	Description	Size	Value	Туре	Note
Q1	BFU730F	2X2mm		NXP Semiconductors	НВТ
PCB		20X35mm			
C1	Capacitor	0402	100 pF	MurataGRM1555	DC block
C3	Capacitor	0402	68 nF	MurataGRM1555	Bias Decoupling
C4	Capacitor	0402	6.8 pF	MurataGRM1555	Bias Decoupling
C5	Capacitor	0402	1 pF	MurataGRM1555	Bias Decoupling
C6	Capacitor	0402	3.3 pF	MurataGRM1555	output match
C7	Capacitor	0402	4.7 pF	MurataGRM1555	output match
L1	Inductor	0402	1.5 nH	Murata LQW15	input match
L2	Inductor	0402	8.7 nH	Murata LQW15	input match
L3	Inductor	0402	4.7 nH	Murata LQW15	output match
L3	Inductor	0402	3.6 nH	Murata LQP15	output match
R1	Resistor	0402	37 K		Bias Setting
R2	Resistor	0402	100 R		Bias Setting Hfe and Temp spread cancellation
R3	Resistor	0402	10 Ohm		Stability
R4	Resistor	0402	0 R		NA
X1,X2	SMA RF connector	-		Johnson, End launch SMA 142-0701-841	RF input/ RF output
Х3	DC header	-		Molex, PCB header, Right Angle, 1 row, 3 way 90121- 0763	Bias connector

4.3 PCB layout.

A good PCB Layout is an essential part of an RF circuit design. The EVB of the BFU730 can serve as a guideline for laying out a board using either the BFU730 or one of the other SiGe.C HBTs in the SOT343F package. Use controlled impedance lines for all high frequency inputs and outputs. Bypass V_{CC} with decoupling capacitors, preferable located as close as possible to the device. For long bias lines it may be necessary to add decoupling capacitors along the line further away from the device. Proper grounding the emitters is also essential for the performance. Either connect the emitters directly to the

ground plane ore through vias, or do both. The material that has been used for the EVB is FR4 using the stack shown in Fig 7



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4.4 LNA View

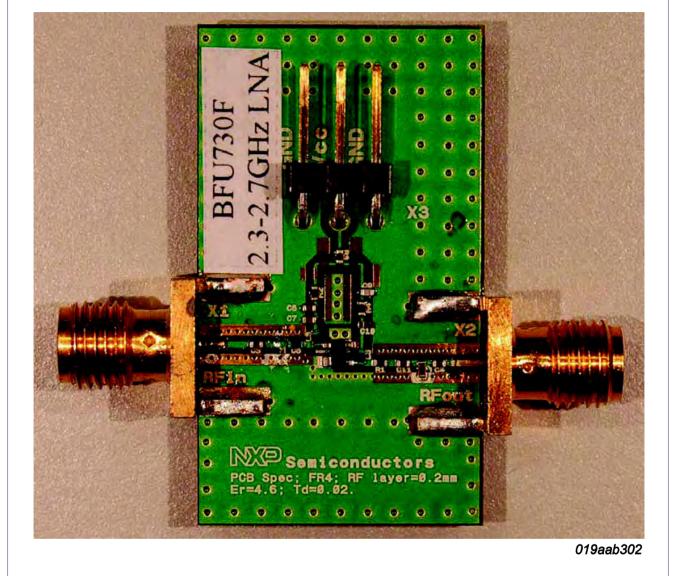


Fig 8. 2.3_2.7 GHz LNA

4.5 Measurement results

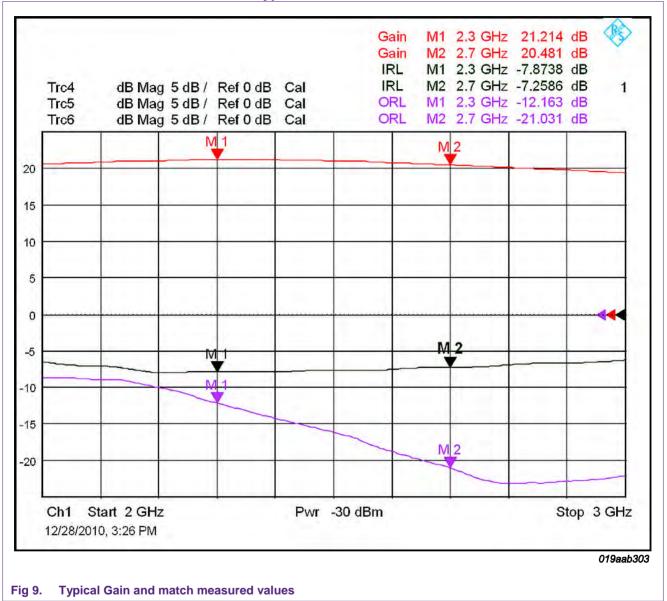
Parameter		Symbol	Value	Unit Remarks	
Supply Voltage		V _{cc}	3	V	
Supply Current		Icc	10	mA	
Noise Figure		NF ^[1]	0.8	dB	
	2.3 GHz		21.2	dB	
Power Gain	2.5 GHz	GP	21	dB	
	2.7 GHz		20.5	dB	
Input return Loss		IRL	7.9	dB	
Output return Loss		ORL	17.5	dB	
Input 1dB Gain compression Point		P _i 1dB	-16.5	dBm	
Output 1dB Gain compression Point		P₀1dB	+3.7	dBm	
Input third order intercept point		IP3 _i	+1.5	dBm	
Output third order intercept point		IP3 _o	+22.5	dBm	
Power settling time		Ton	124	ns	
		Toff	176	ns	

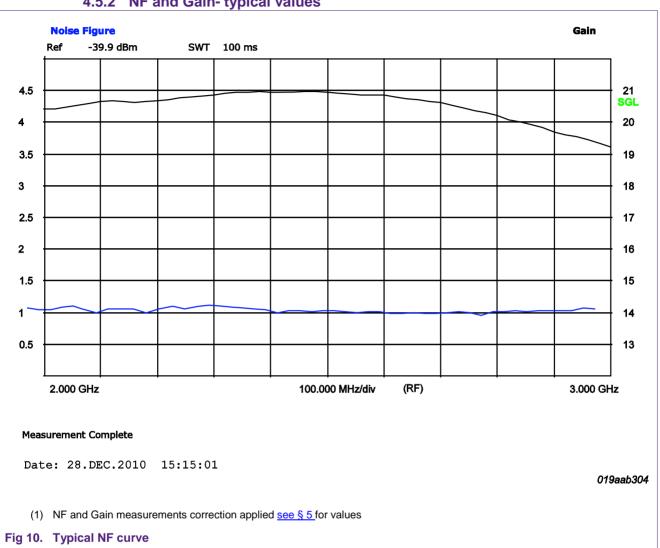
 Table 3.
 Typical measurement results measured on the evaluation board.

 Temp=25 °C, frequency is 2.5GHz unless otherwise specified.

[1] The NF and gain figures are being measured at the SMA connectors of the evaluation board, so losses of the connectors and the PCB of approximately 0.1 dB are not substracted

4.5.1 Gain and match - typical values



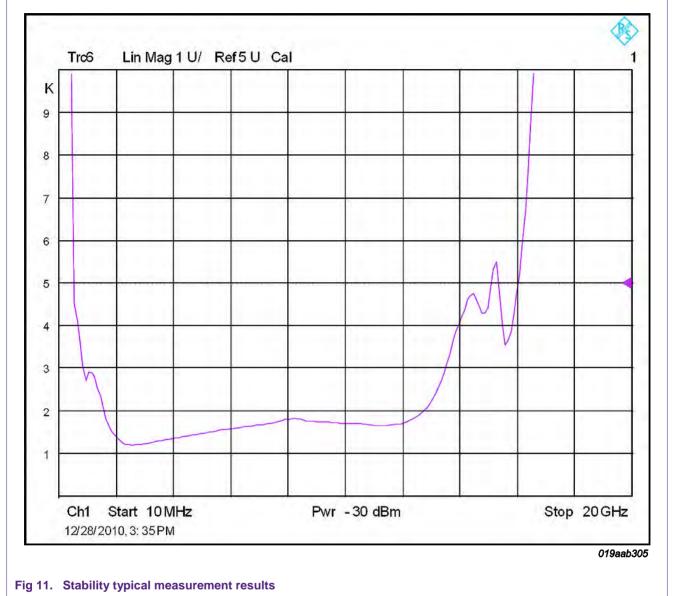


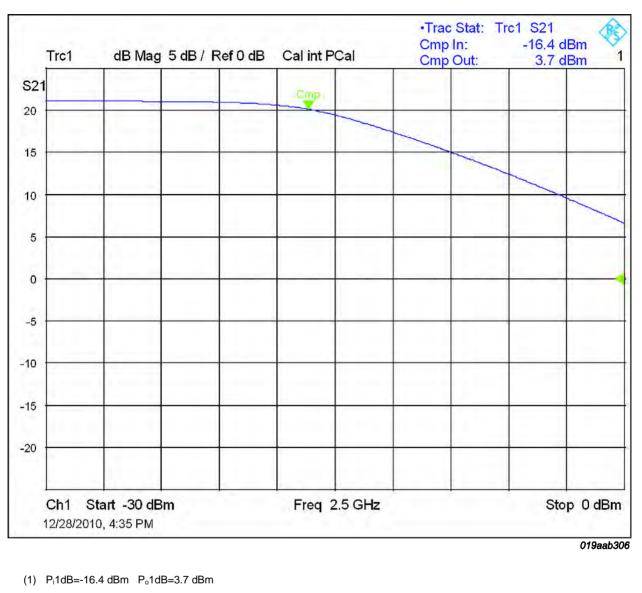
4.5.2 NF and Gain- typical values

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4.5.3 Stability



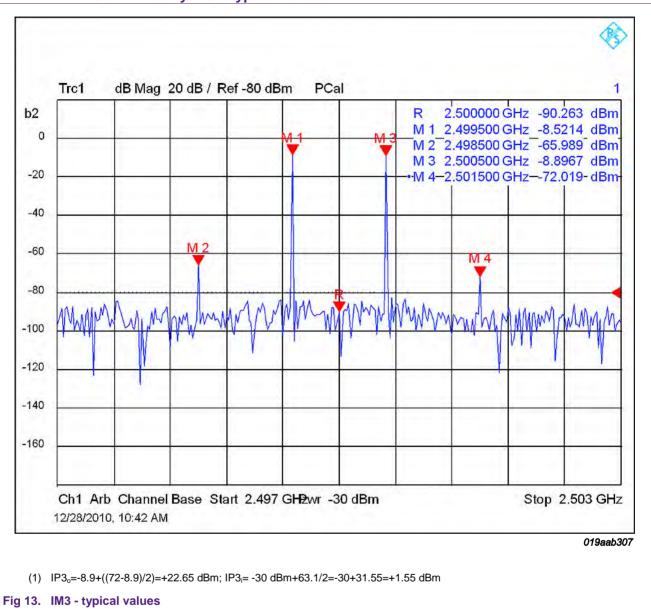


4.5.4 1dB compression point typical values.

Fig 12. Typical 1 dB compression point curve.

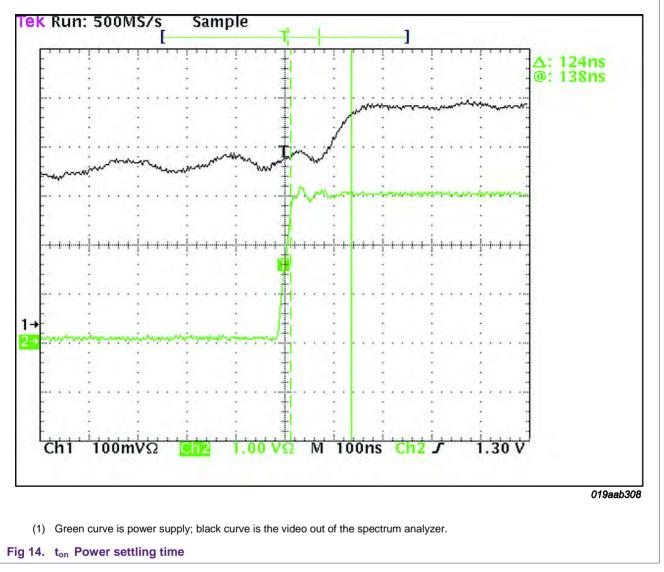
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4.5.5 Linearity IP3 – typical values

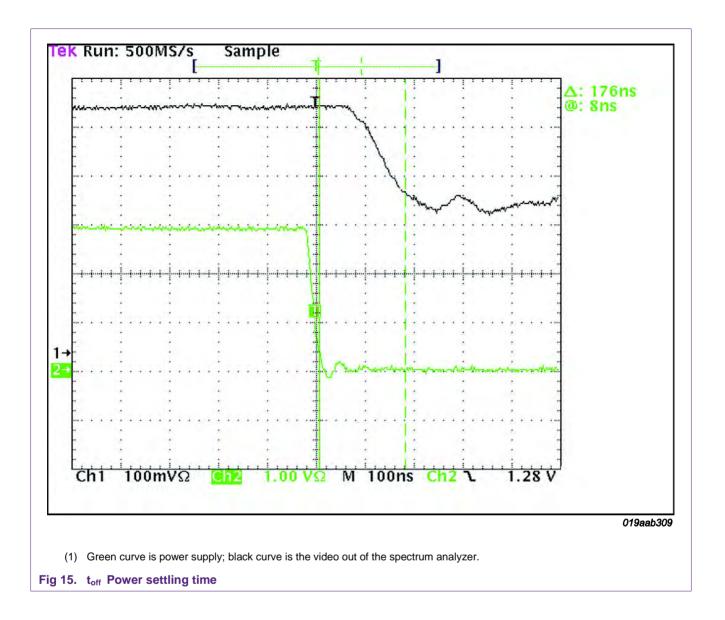
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4.5.6 Power settling time

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5. NF measurement corrections

There are two types of errors and losses that have been taken into account to correct the NF measurement results: (1) Own system error for NF measurement and (2) insertion losses accounted to RF IN and RF OUT connectors, microstrip feed lines used at the input of the LNA in NF measurements.

5.1 NF measurement system error

A Miteq professional amplifier, rated as NF=0.41 dB, Gain=30 dB, has been used as reference for NF measurement system correction. Its manufacturer data is in Fig 16

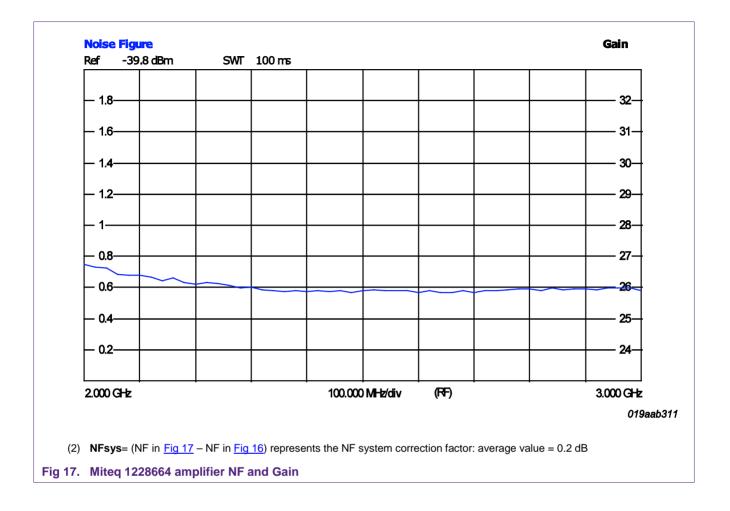
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2	-		nt. Transfer : N/A			CATIONS
n	T=	Cus	tomer P/N : <u>N/A</u>		Frequency (GHz)	2.00 - 4.00 GH
MITEQ. IN		Cus	tomer P. O. : _ 160	8051	Gain (dB)	28.0 08 MIN.
Hauppaug	e, New York 117 436-7400	88-2086 Mo	del Number : AMF-2F	-02000 feo-05-10p	Gain Fiatness (dB)	+1- 2.00 DB MAI
	436-7430	Se	rial Number : 1228	664	∆ Gain vs. Temp (dB)	NA
		_			VSWR: Input / Output	2.00:1 MAX
NOTE - This	unit can safely	bandle a mag	rimum input power of	10.0 dBm, CW.	Naise Figure (dB)	0.50 DB MA
					Pour @ 1 dB Comp (dBm)	+10.0 DBM MI
		TEST DA	ATA at + 25° C		Output IP3 (dBm)	NA
Frequency	Noise Fig		P. @ 1 dB Comp	Output IP3	Yoltage (VDC)	+15.0 VDC
(GHz)			(dBm)	(dBm)	Current (mA)	100 m.A. Non
2:00	07	41	+ 14.5	NK	Operating Temp (°C)	+25.0°C
3.00	0.4	2	+ 14.9	(Outline Drawing	131580
4.00	0	42	+ 15.3	VA		
					Measured Carrent :	
Mazimum Input VSWR Mazimum Outp		a Output VSWR	Tested By	· TOW AND	RSEN	
1.50:1 1.63		:1	Date	10-04-06	,	

Miteq 1228664 amplifier measured with the NF setup used to qualify the BFU730F 2.3-2.7GHz LNA has the NF performances listed in Fig 17. The system correction factor, NFsys, is the difference between the NF measured and the 0.42 dB value from the catalog. At 2GHz this difference is about 0.3 dB and at 3 GHz around 0.15 dB.

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5.2 Insertion losses.

Insertion losses have not been taken in to account so measurements are referenced to the SMA connectors.

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